

MOSFET – Complementary, POWERTRENCH®

N-Channel: 20 V, 3.8 A, 66 mΩ

P-Channel: -20 V, -2.6 A, 142 mΩ

FDME1034CZT

General Description

This device is designed specifically as a single package solution for a DC-DC ‘Switching’ MOSFET in cellular handset and other ultra-portable applications. It features an independent N-Channel & P-Channel MOSFET with low on-state resistance for minimum conduction losses. The gate charge of each MOSFET is also minimized to allow high frequency switching directly from the controlling device.

The MicroFET™ 1.6x1.6 Thin package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.

Features

Q1: N-Channel

- Max $R_{DS(on)}$ = 66 mΩ at $V_{GS} = 4.5$ V, $I_D = 3.4$ A
- Max $R_{DS(on)}$ = 86 mΩ at $V_{GS} = 2.5$ V, $I_D = 2.9$ A
- Max $R_{DS(on)}$ = 113 mΩ at $V_{GS} = 1.8$ V, $I_D = 2.5$ A
- Max $R_{DS(on)}$ = 160 mΩ at $V_{GS} = 1.5$ V, $I_D = 2.1$ A

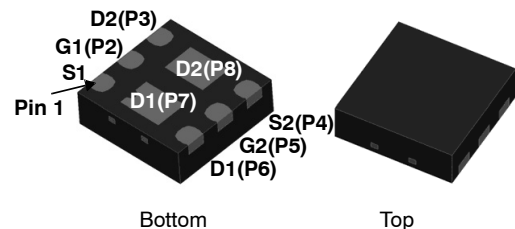
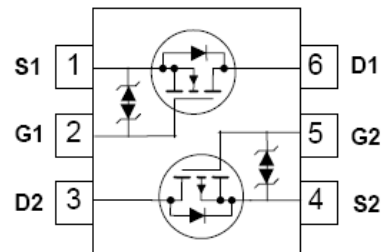
Q2: P-Channel

- Max $R_{DS(on)}$ = 142 mΩ at $V_{GS} = -4.5$ V, $I_D = -2.3$ A
- Max $R_{DS(on)}$ = 213 mΩ at $V_{GS} = -2.5$ V, $I_D = -1.8$ A
- Max $R_{DS(on)}$ = 331 mΩ at $V_{GS} = -1.8$ V, $I_D = -1.5$ A
- Max $R_{DS(on)}$ = 530 mΩ at $V_{GS} = -1.5$ V, $I_D = -1.2$ A
- Low Profile: 0.55 mm Maximum in the New Package MicroFET 1.6x1.6 Thin
- Free from Halogenated Compounds and Antimony Oxides
- HBM ESD Protection Level > 1600 V (Note 3)
- This Device is Pb-Free and is RoHS Compliant

Applications

- DC-DC Conversion
- Level Shifted Load Switch

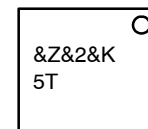
ELECTRICAL CONNECTION



Note: Center pad of P7 & P8 is a virtual pin number. Actual P7 & P8 is connected to edge pad of P6 & P3 respectively.

**UDFN6 1.6x1.6, 0.5P
CASE 517DW**

MARKING DIAGRAM



&Z	= Assembly Plant Code
&2	= 2-Digit Date Code (YW)
&K	= 2-Digit Lot Traceability Code
5T	= Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping†
FDME1034CZT	UDFN6 (Pb-Free)	5,000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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MOSFET MAXIMUM RATINGS (T_A = 25°C, Unless otherwise noted)

Symbol	Parameter			Q1	Q2	Units
V _{DS}	Drain to Source Voltage			20	−20	V
V _{GS}	Gate to Source Voltage			±8	±8	V
I _D	Drain Current	−Continuous	T _A = 25°C (Note 1a)	3.8	−2.6	A
	−Pulsed			6	−6	
P _D	Power Dissipation for Single Operation T _A = 25°C (Note 1a)			1.4		W
	Power Dissipation for Single Operation T _A = 25°C (Note 1b)			0.6		
T _J , T _{STG}	Operating and Storage Junction Temperature Range			−55 to +150		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Units
R _{θJA}	Thermal Resistance, Junction to Ambient (Single Operation) (Note 1a)	90	°C/W
R _{θJA}	Thermal Resistance, Junction to Ambient (Single Operation) (Note 1b)	195	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Type	Min.	Typ.	Max.	Units
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OFF CHARACTERISTICS

BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V I _D = -250 μA, V _{GS} = 0 V	Q1 Q2	20 -20	- -	- -	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C I _D = -250 μA, referenced to 25°C	Q1 Q2	- -	16 -12	- -	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V V _{DS} = -16 V, V _{GS} = 0 V	Q1 Q2	- -	- -	1 -1	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±8 V, V _{DS} = 0 V	All	-	-	±10	μA

ON CHARACTERISTICS

V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA V _{GS} = V _{DS} , I _D = -250 μA	Q1 Q2	0.4 -0.4	0.7 -0.6	1.0 -1.0	V
ΔV _{GS(th)} ΔT _J	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C I _D = -250 μA, referenced to 25°C	Q1 Q2	- -	-3 2	- -	mV/°C
R _{DS(on)}	Drain to Source On Resistance	V _{GS} = 4.5 V, I _D = 3.4 A V _{GS} = 2.5 V, I _D = 2.9 A V _{GS} = 1.8 V, I _D = 2.5 A V _{GS} = 1.5 V, I _D = 2.1 A V _{GS} = 4.5 V, I _D = 3.4 A, T _J = 125°C	Q1	- - - - -	55 68 85 106 76	66 86 113 160 112	mΩ
		V _{GS} = -4.5 V, I _D = -2.3 A V _{GS} = -2.5 V, I _D = -1.8 A V _{GS} = -1.8 V, I _D = -1.5 A V _{GS} = -1.5 V, I _D = -1.2 A V _{GS} = -4.5 V, I _D = -2.3 A, T _J = 125°C	Q2	- - - - -	95 120 150 190 128	142 213 331 530 190	
g _{FS}	Forward Transconductance	V _{DS} = 4.5 V, I _D = 3.4 A V _{DS} = -4.5 V, I _D = -2.3 A	Q1 Q2	- -	9 7	- -	S

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Type	Min.	Typ.	Max.	Units
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DYNAMIC CHARACTERISTICS

C_{iss}	Input Capacitance	Q1: $V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$ Q2: $V_{DS} = -10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	Q1	–	225	300	pF
C_{oss}	Output Capacitance		Q2	–	305	405	pF
C_{rss}	Reverse Transfer Capacitance		Q1	–	40	55	pF
			Q2	–	55	75	pF
			Q1	–	25	40	pF
			Q2	–	50	75	pF

SWITCHING CHARACTERISTICS

$t_{d(on)}$	Turn-On Delay Time	Q1: $V_{DD} = 10\text{ V}$, $I_D = 1\text{ A}$, $V_{GS} = 4.5\text{ V}$, $R_{GEN} = 6\ \Omega$ Q2: $V_{DD} = -10\text{ V}$, $I_D = -1\text{ A}$, $V_{GS} = -4.5\text{ V}$, $R_{GEN} = 6\ \Omega$	Q1	–	4.5	10	ns
t_r	Rise Time		Q2	–	4.7	10	
$t_{d(off)}$	Turn-Off Delay Time		Q1	–	2.0	10	
t_f	Fall Time		Q2	–	4.8	10	
			Q1	–	15	27	nC
			Q2	–	33	53	
			Q1	–	1.7	10	
			Q2	–	16	29	
Q_g	Total Gate Charge	Q1: $V_{DD} = 10\text{ V}$, $I_D = 3.4\text{ A}$, $V_{GS} = 4.5\text{ V}$ Q2: $V_{DD} = -10\text{ V}$, $I_D = -2.3\text{ A}$, $V_{GS} = -4.5\text{ V}$	Q1	–	3	4.2	nC
Q_{gs}	Gate to Source Gate Charge		Q2	–	5.5	7.7	
Q_{gd}	Gate to Drain “Miller” Charge		Q1	–	0.4	–	
			Q2	–	0.6	–	
			Q1	–	0.6	–	nC
			Q2	–	1.4	–	

DRAIN-SOURCE DIODE CHARACTERISTICS $T_J = 25^\circ\text{C}$ unless otherwise noted.

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}$, $I_S = 0.9\text{ A}$ (Note 2) $V_{GS} = 0\text{ V}$, $I_S = -0.9\text{ A}$ (Note 2)	Q1	–	0.7	1.2	V
t_{rr}	Reverse Recovery Time	Q1: $I_F = 3.4\text{ A}$, $\Delta i/\Delta t = 100\text{ A}/\mu\text{s}$ Q2: $I_F = -2.3\text{ A}$, $\Delta i/\Delta t = 100\text{ A}/\mu\text{s}$	Q1	–	8.5	17	ns
Q_{rr}	Reverse Recovery Charge		Q2	–	16	29	
			Q1	–	1.4	10	nC
			Q2	–	4.4	10	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 90°C/W when mounted on a 1 in² pad of 2 oz copper



b. 195°C/W when mounted on a minimum pad of 2 oz copper

- Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0 %.
- The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) $T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED.

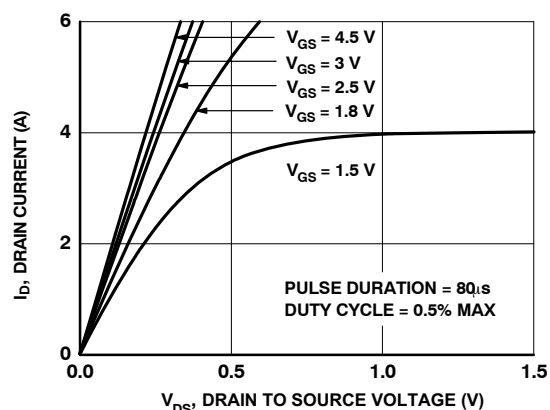


Figure 1. On-Region Characteristics

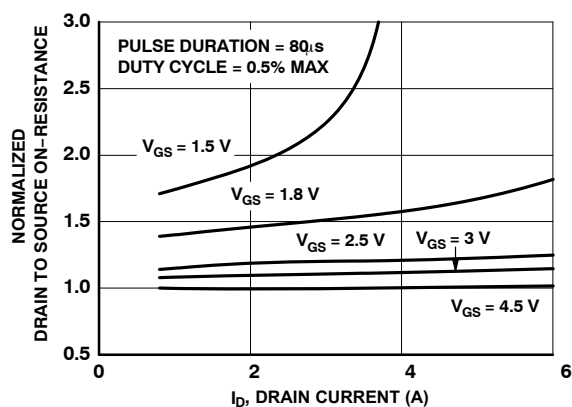


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

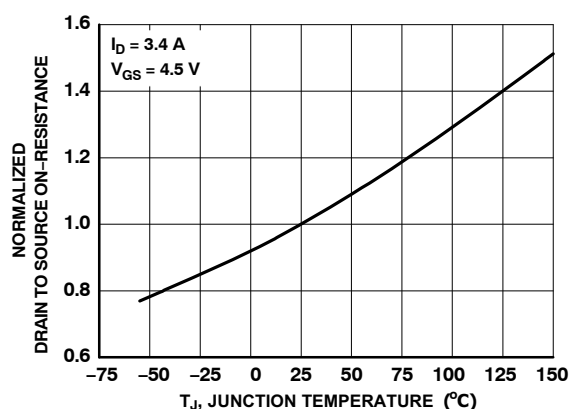


Figure 3. Normalized On Resistance vs. Junction Temperature

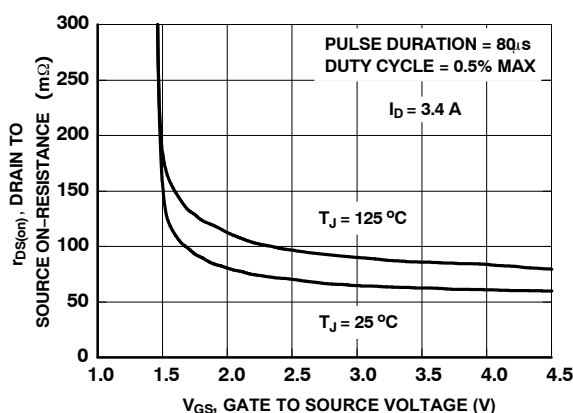


Figure 4. On-Resistance vs. Gate to Source Voltage

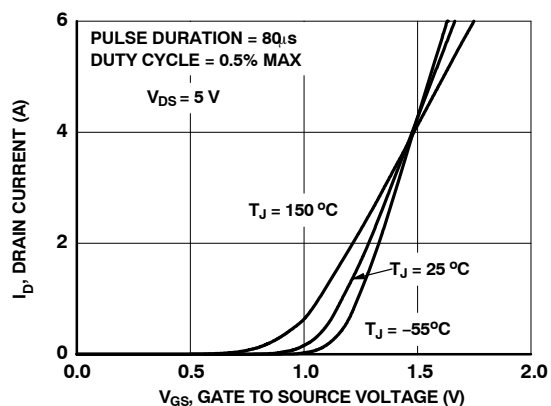


Figure 5. Transfer Characteristics

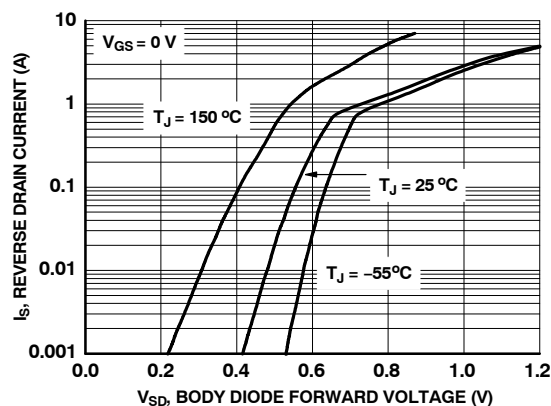


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) $T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED.

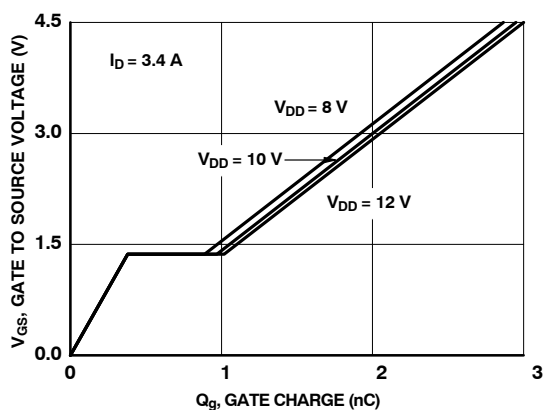


Figure 7. Gate Charge Characteristics

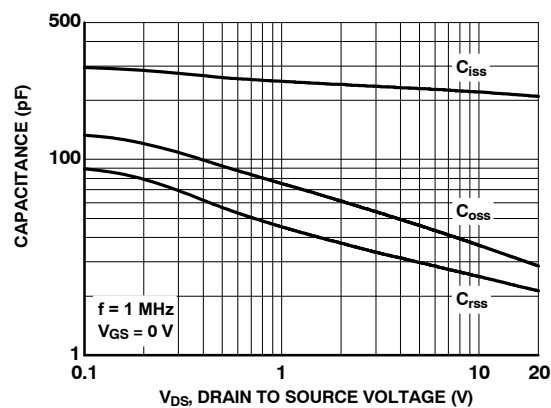


Figure 8. Capacitance vs. Drain to Source Voltage

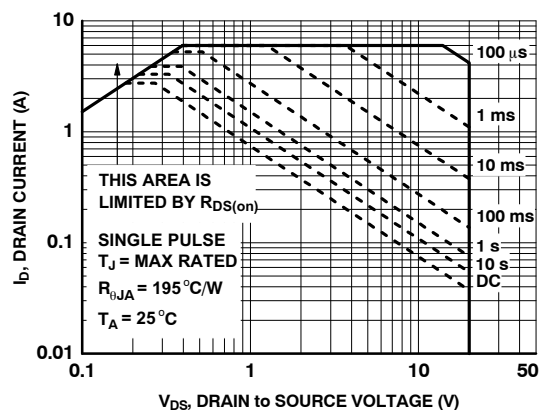


Figure 9. Forward Bias Safe Operating Area

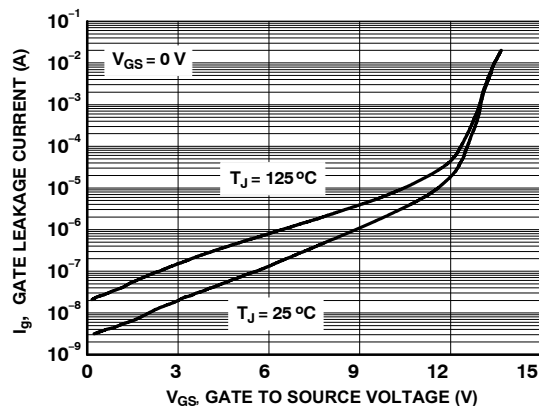


Figure 10. Gate Leakage Current vs. Gate to Source Voltage

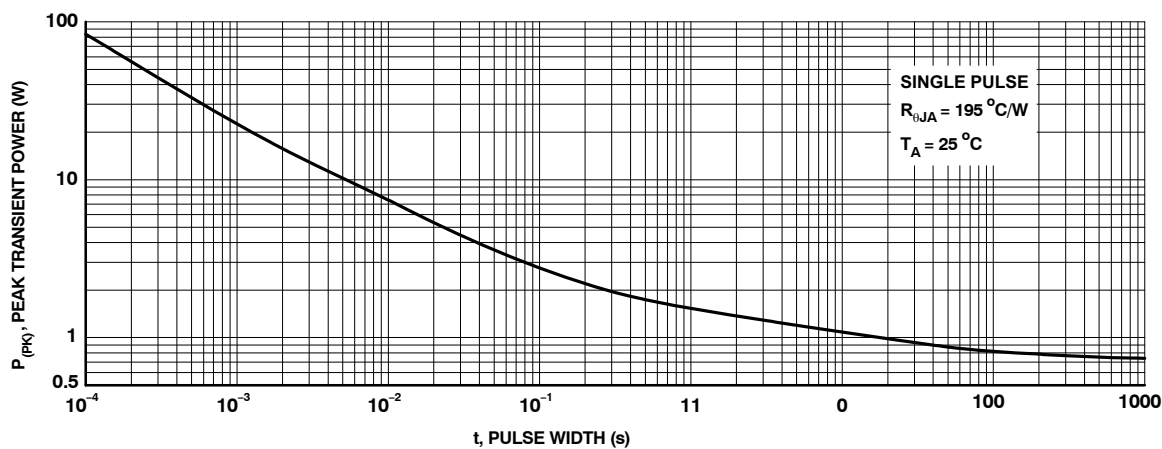


Figure 11. Single Pulse Maximum Power Dissipation

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TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) $T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED.

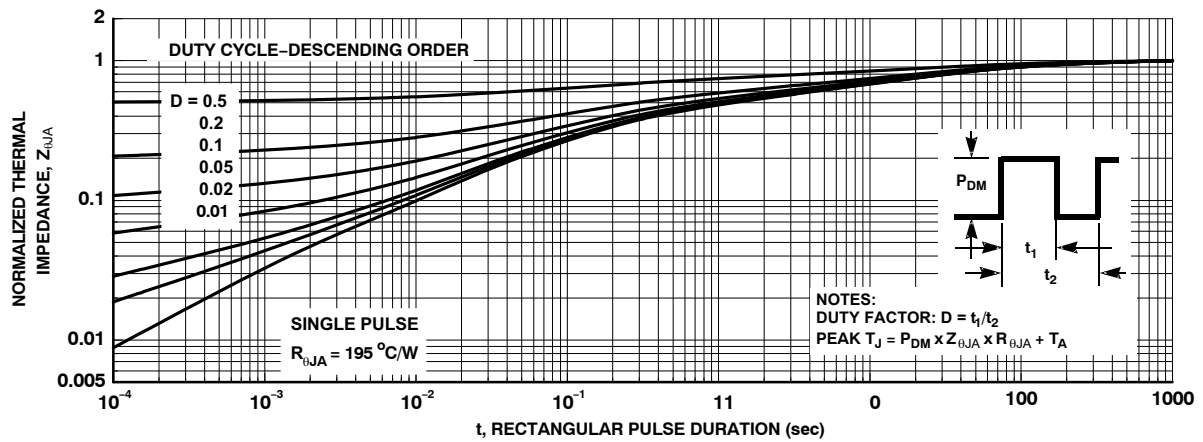


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

TYPICAL CHARACTERISTICS (Q2 P-CHANNEL) $T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED.

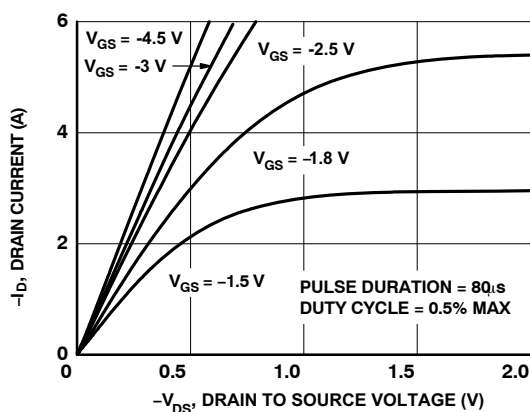


Figure 13. On-Region Characteristics

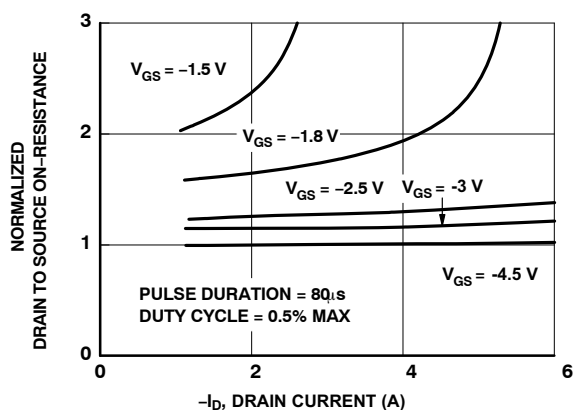


Figure 14. Normalized On-Resistance vs. Drain Current and Gate Voltage

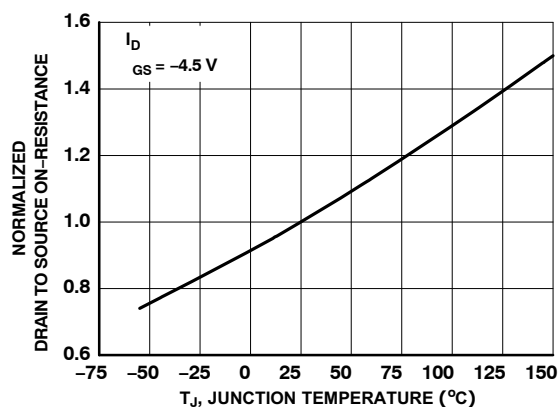


Figure 15. Normalized On-Resistance vs. Junction Temperature

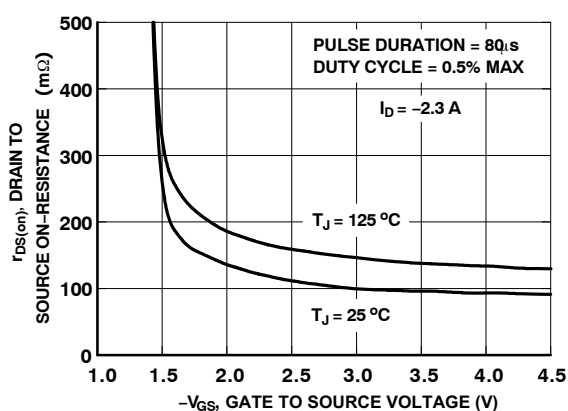


Figure 16. On Resistance vs. Gate to Source Voltage

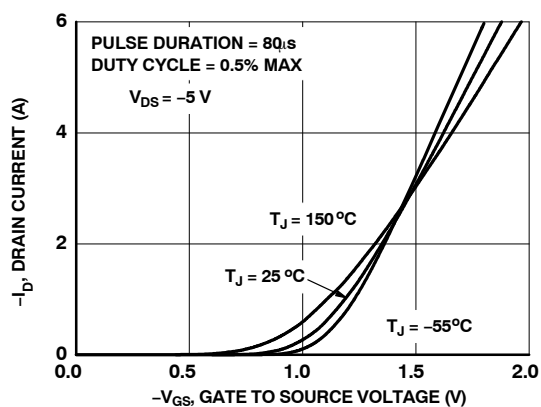


Figure 17. Transfer Characteristics

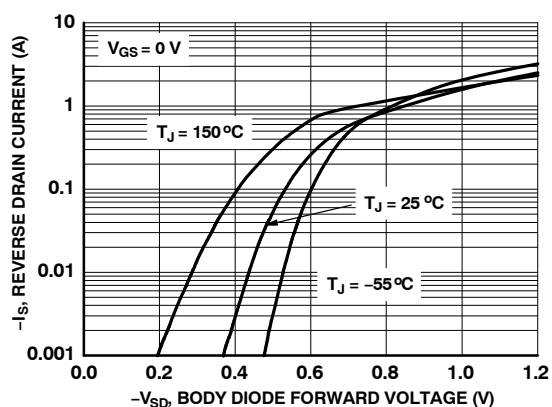


Figure 18. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL) $T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED.

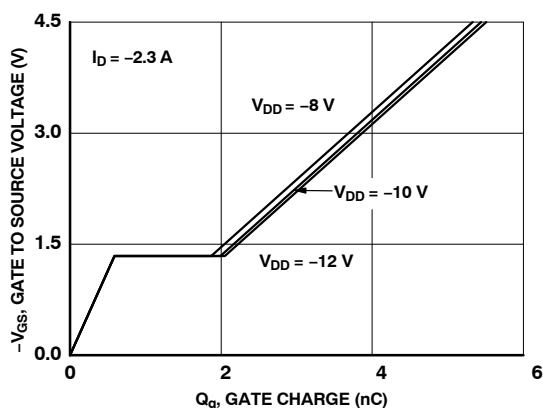


Figure 19. Gate Charge Characteristics

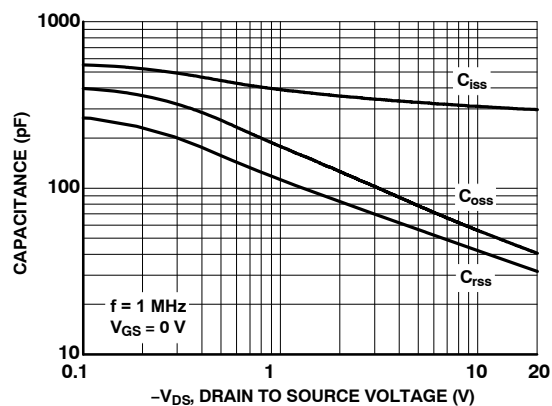


Figure 20. Capacitance vs. Drain to Source Voltage

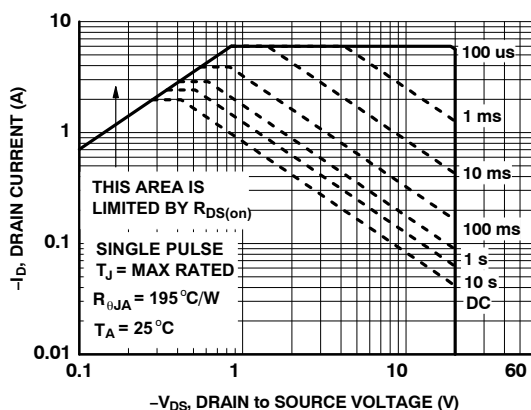


Figure 21. Forward Bias Safe Operating Area

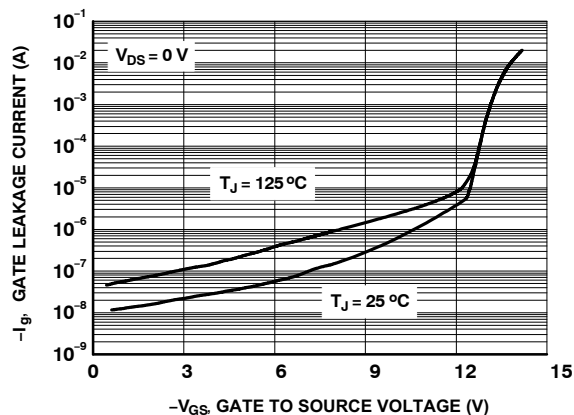


Figure 22. Gate Leakage Current vs. Gate to Source Voltage

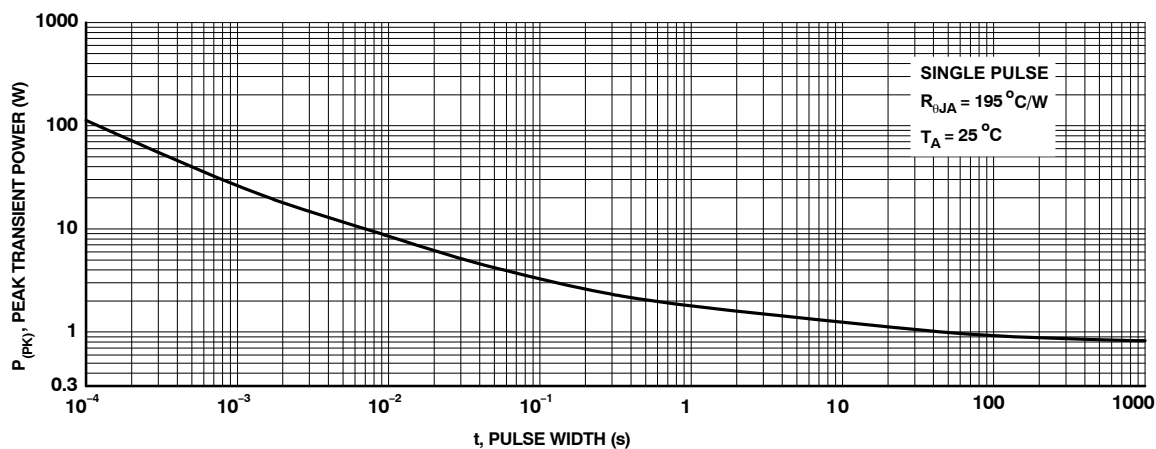


Figure 23. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (Q2 P-CHANNEL) $T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED.

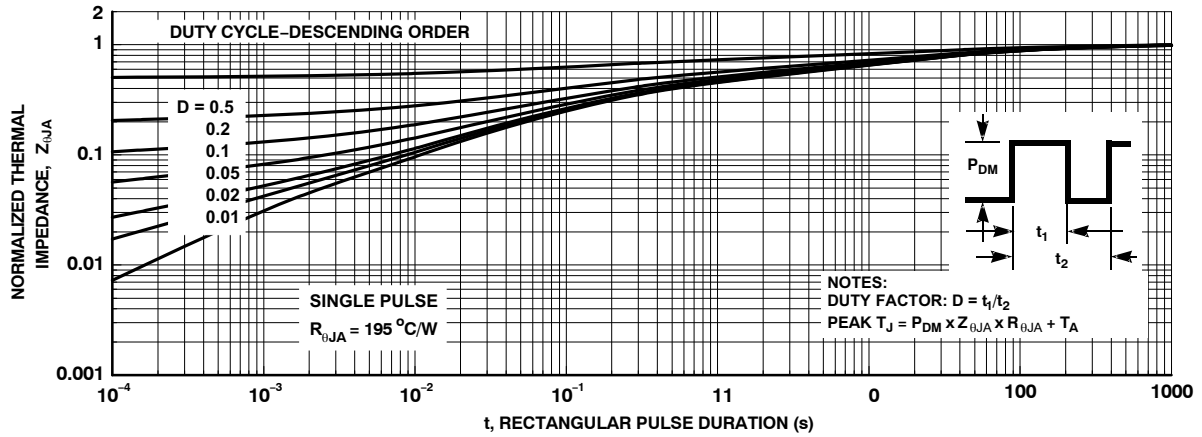
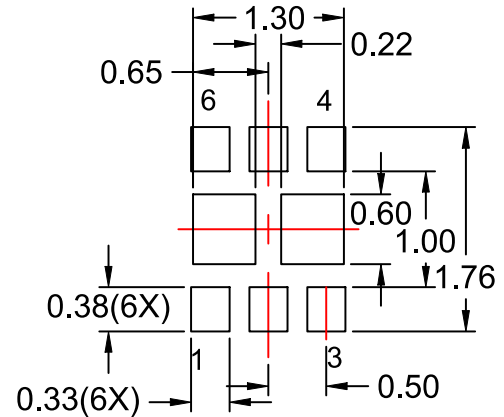
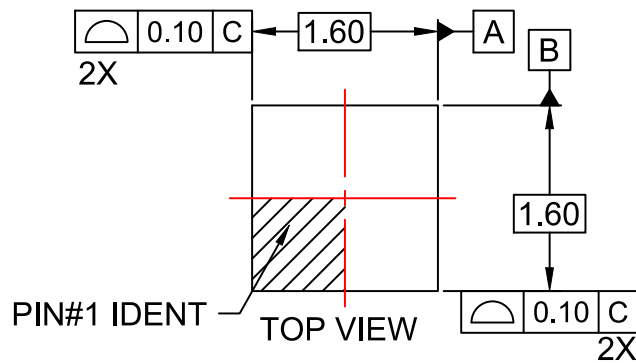


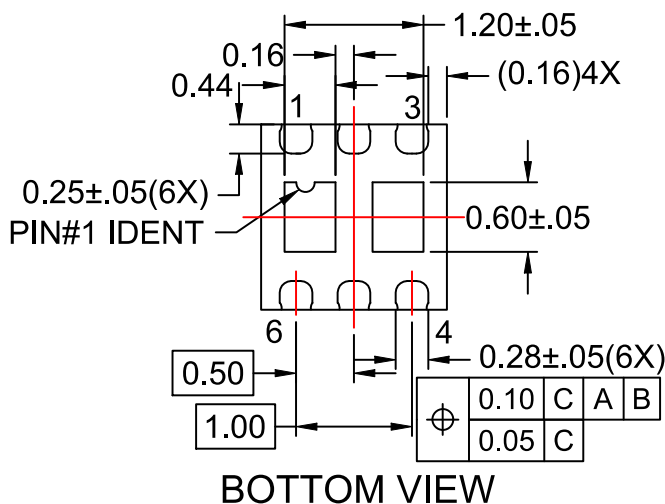
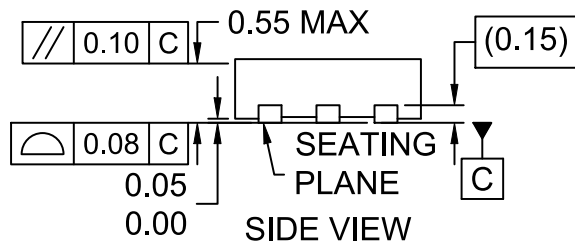
Figure 24. Junction –to–Ambient Transient Thermal Response Curve

UDFN6 1.6x1.6, 0.5P
CASE 517DW
ISSUE O

DATE 31 OCT 2016



**RECOMMENDED
LAND PATTERN**



NOTES:

- A. PACKAGE DOES NOT CONFORM TO ANY JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

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